Search Notes

Applica	tion	/Con	itrol	No.

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Applicant(s)/Patent under Reexamination

10/625,792

MANDRO ET AL.
Art Unit

Examiner

Patrick J. Lee

2878

SEARCHED				
Class	Subclass	Date	Examiner	
250	221, 222.1, 231.1, 231.13	12/23/2005	PL	
250	231.14	12/23/2005	PL	
250	231.18	12/23/2005	PL	
341	13, 141	12/23/2006	PL	
Updated	search	5/30/2006	PL	
Updated	search	9/21/2006	PL	
Updated	search	6/20/2007	PL	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	12/23/2005	PL		
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	5/30/2006	PL		
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	9/21/2006	PL		
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	6/20/2007	PL		